

Product Summary

$V_{(BR)DSS}$	$R_{DS(on)TYP}$	I_D
100V	70mΩ@10V	15A

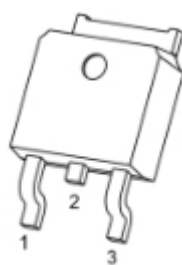
Feature

- $V_{DS} = 100V$, $I_D = 15A$
 $R_{DS(on)} < 85m\Omega @ V_{GS} = 10V$
 $R_{DS(on)} < 110m\Omega @ V_{GS} = 4.5V$
- Green Device Available
- Low Gate Charge
- Advanced High Cell Density Trench Technology
- 100% EAS Guaranteed

Application

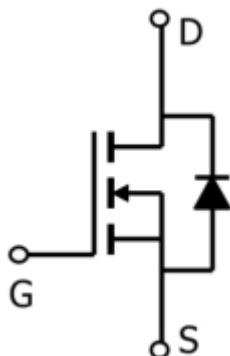
- Power Management Switches
- DC/DC Converters

Package



TO-252(G:1 D:2 S:3)

Circuit diagram



Marking



Absolute maximum ratings

(T_a=25°C unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V _{DS}	100	V
Gate-Source Voltage	V _{GS}	±20	V
Continuous Drain Current@10V	I _D	T _A =25°C 15	W
		T _C =25°C 10	
Pulsed Drain Current	I _{DM}	58	A
Single Pulse Avalanche Energy ¹	E _{AS}	3.2	mJ
Avalanche Current	I _{AS}	8	A
Total Power Dissipation	P _D	T _C =25°C 41.7	W
Thermal Resistance,Junction-to-Ambient	R _{θJA}	50	°C/ W
Thermal Resistance Junction-to-Case	R _{θJC}	3	°C/ W
Operating Junction and Storage Temperature Range	T _J , T _{STG}	-55~ +150	°C

Electrical characteristics

(T_A=25°C, unless otherwise noted)

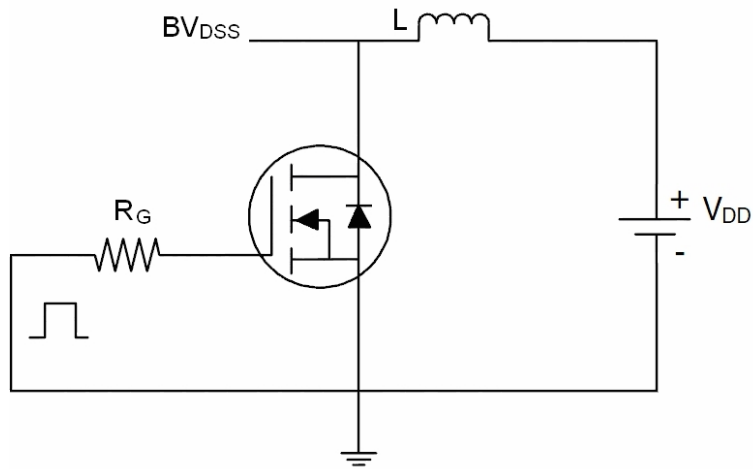
Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Static Characteristics						
Drain-source breakdown voltage	BV _{DSS}	V _{GS} = 0V, I _D =250μA	100			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =100V,V _{GS} = 0V			1	uA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V , V _{DS} =0V			±100	uA
Gate threshold voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250μA	1.2		2.5	V
Drain-Source On-State Resistance ²	R _{DS(on)}	V _{GS} =10V, I _D =5A		70	85	mΩ
		V _{GS} =4.5V, I _D =3A		85	110	
Dynamic characteristics						
Input Capacitance	C _{iss}	V _{DS} =15V,V _{GS} =0V, f=1MHz		1100		pF
Output Capacitance	C _{oss}			55		
Reverse Transfer Capacitance	C _{rss}			40		
Switching Characteristics						
Turn-On Delay Time	T _{d(on)}	V _{GS} =10V, V _{DD} =50V, R _G =3Ω, I _D =5A		3.9		nS
Rise Time	T _r			26		
Turn-Off Delay Time	T _{d(off)}			16.2		
Fall Time	T _f			8.9		
Total Gate Charge	Q _g	V _{GS} =10V, V _{DS} =50V, I _D =5A		12		nC
Gate-Source Charge	Q _{gS}			2.9		
Gate-Drain Charge	Q _{gd}			1.8		
Drain-Source Diode Characteristics						
Diode forward voltage	V _{SD}	V _{GS} =0V, I _S =1A			1.2	V
Diode Forward Current	I _S				15	A

Notes:

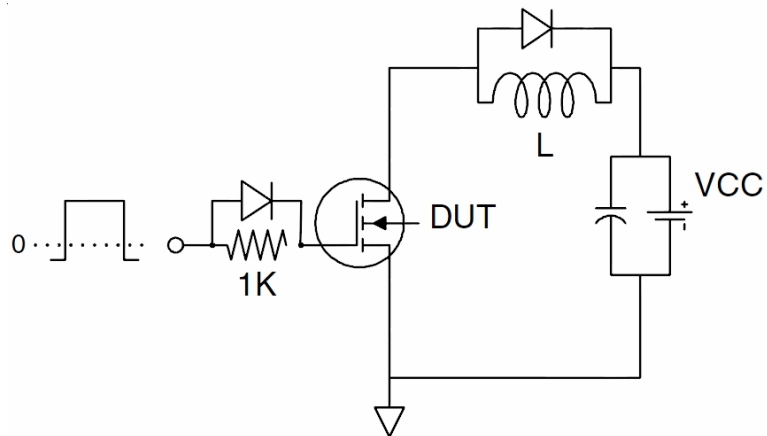
1. EAS condition: V_{DD} = 25V, V_{GS} = 10V, L = 0.1mH, I_{AS} = 8A

Test Circuit

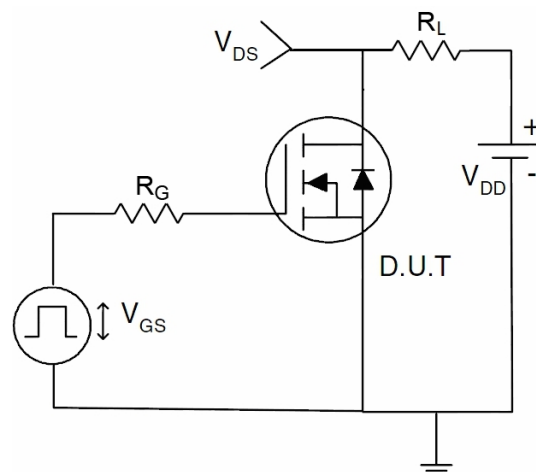
- EAS Test Circuits



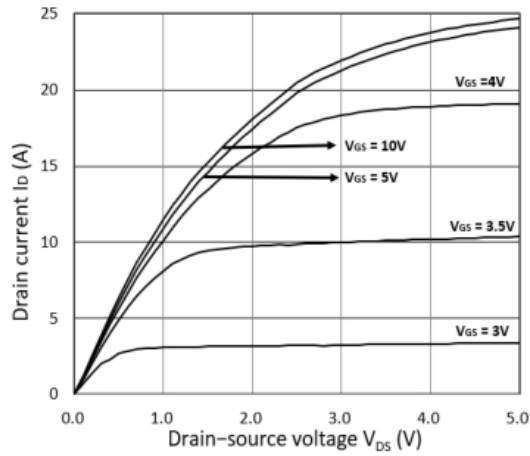
- Gate Charge Test Circuit



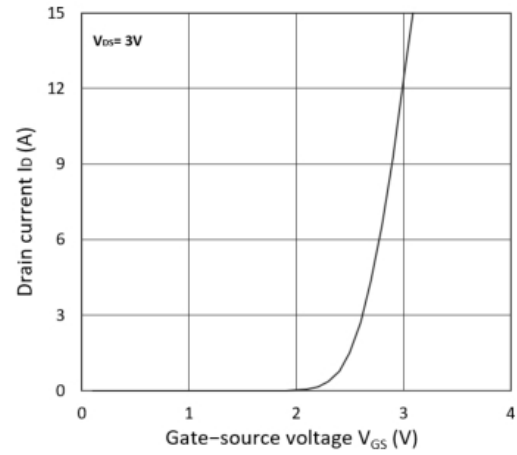
- Switch Time Test Circuit



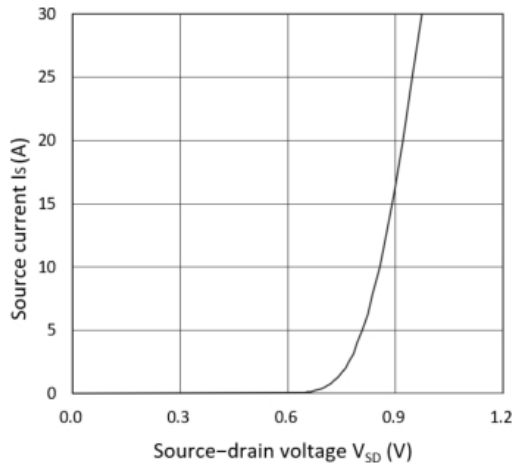
Typical Characteristics



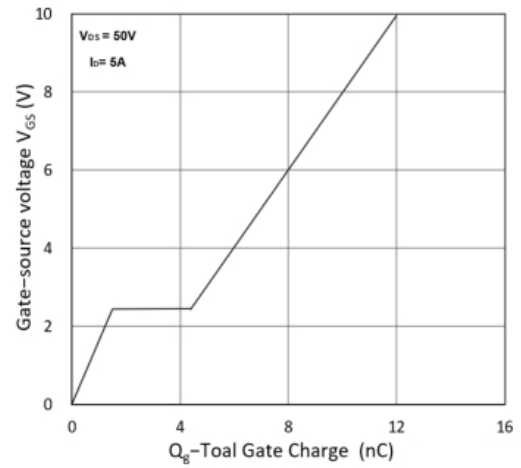
Output Characteristics



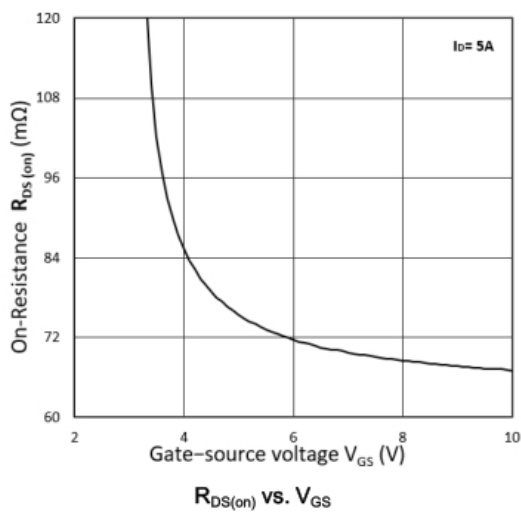
Transfer Characteristics



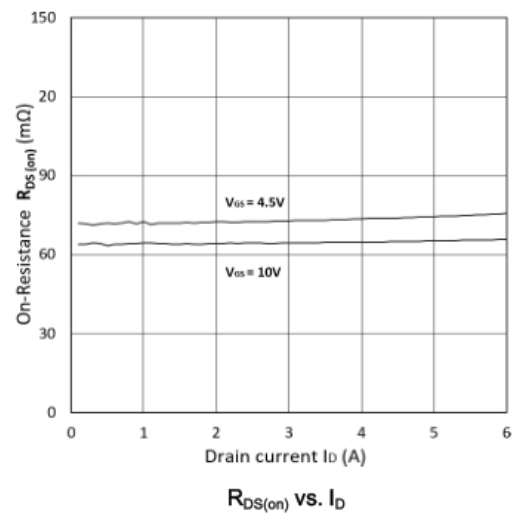
Forward Characteristics of Reverse



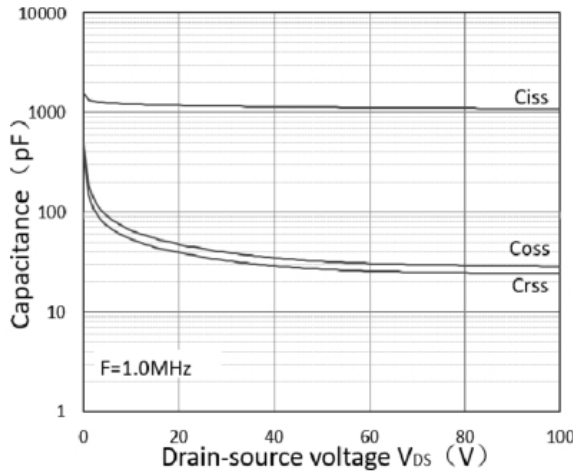
Gate Charge Characteristics



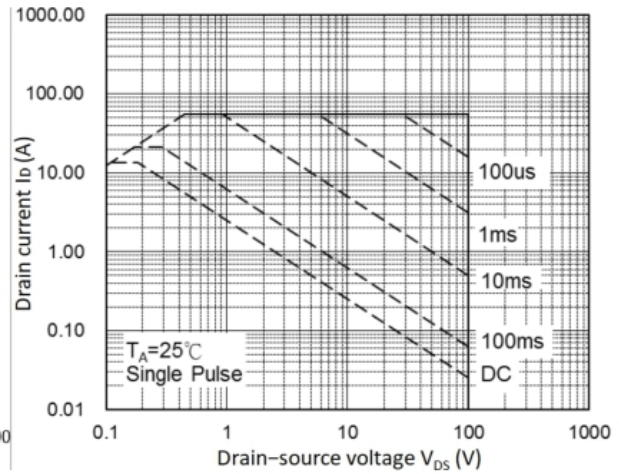
$R_{DS(on)}$ vs. V_{GS}



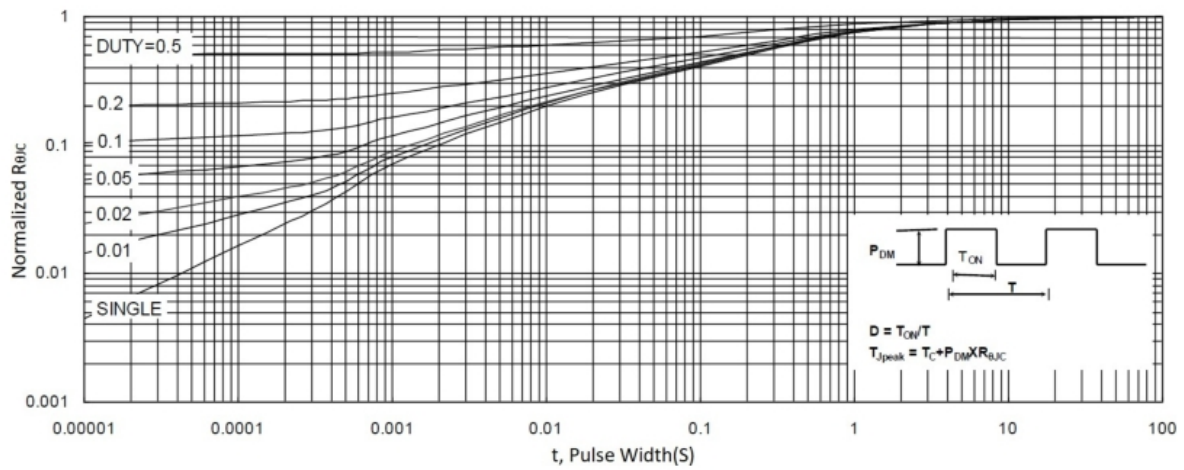
$R_{DS(on)}$ vs. I_D



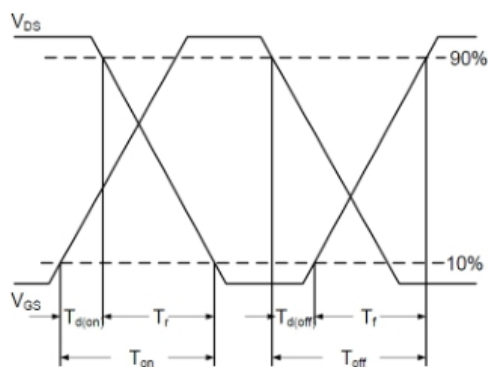
Capacitance Characteristics



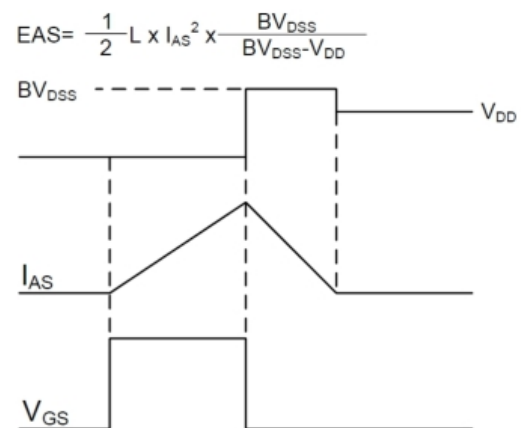
Safe Operating Area



Normalized Maximum Transient Thermal Impedance

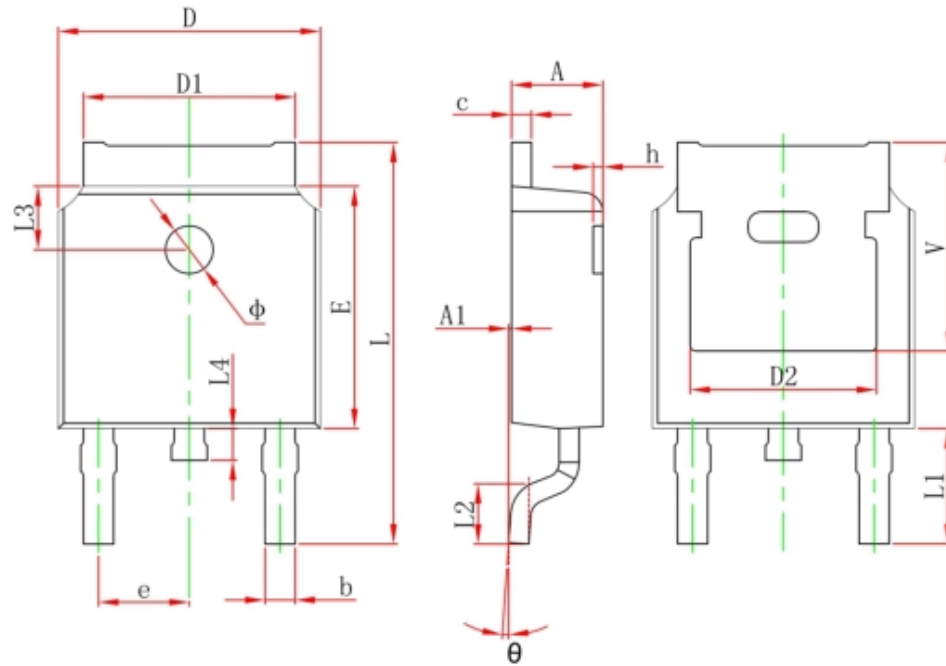


Switching Time Waveform



Unclamped Inductive Switching Waveform

SOP-252 Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	2.200	2.400	0.087	0.094
A1	0.000	0.127	0.000	0.005
b	0.660	0.860	0.026	0.034
c	0.460	0.580	0.018	0.023
D	6.500	6.700	0.256	0.264
D1	5.100	5.460	0.201	0.215
D2	4.830 REF.		0.190 REF.	
E	6.000	6.200	0.236	0.244
e	2.186	2.386	0.086	0.094
L	9.800	10.400	0.386	0.409
L1	2.900 REF.		0.114 REF.	
L2	1.400	1.700	0.055	0.067
L3	1.600 REF.		0.063 REF.	
L4	0.600	1.000	0.024	0.039
Φ	1.100	1.300	0.043	0.051
θ	0°	8°	0°	8°
h	0.000	0.300	0.000	0.012
V	5.350 REF.		0.211 REF.	